TOSHIBA Transistor Silicon NPN Epitaxial Type (PCT Process)

HN1C03F

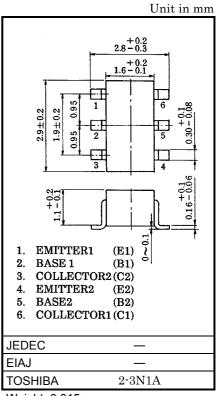
For Muting And Switching Applications

- Including two devices in SM6 (Super mini type with 6 leads)
- High emitter-base voltage: $V_{EBO} = 25V$ (min)
- High reverse hFE: reverse hFE = 150 (typ.)($V_{CE} = -2V$, $I_{C} = -4mA$)
- Low on resistance: $R_{ON} = 1\Omega$ (typ.)(IB = 5mA)

Maximum Ratings (Ta = 25°C) (Q1, Q2 Common)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	V_{CBO}	50	V
Collector-emitter voltage	V _{CEO}	20	V
Emitter-base voltage	V _{EBO}	25	V
Collector current	IC	300	mA
Base current	ΙΒ	60	mA
Collector power dissipation	P _C *	300	mW
Junction temperature	Tj	150	°C
Storage temperature range	T _{stg}	-55~150	°C

^{*} Total rating



Weight: 0.015g

Electrical Characteristics (Ta = 25°C) (Q1,Q2 Common)

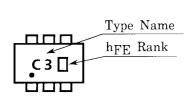
Characteristic Syn		Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current		I _{CBO}	_	$V_{CB} = 50V, I_{E} = 0$	_	-	0.1	μΑ
Emitter cut-	off current	I _{EBO}	_	V _{EB} = 25V, I _C = 0	_	_	0.1	μA
DC current	gain	h _{FE} (Note)	_	V _{CE} = 2V, I _C = 4mA	200	-	1200	
Collector-er saturation v		V _{CE} (sat)	_	I _C = 30mA, I _B = 3mA	_	0.042	0.1	V
Base-emitter voltage		V _{BE}	_	V _{CE} = 2V, I _C = 4mA	_	0.61	_	V
Transition frequency		f _T	_	V _{CE} = 6V, I _C = 4mA	_	30	_	MHz
Collector output capacitance		C _{ob}	-	V _{CB} = 10V, I _E = 0, f = 1MHz	_	4.8	7	pF
Switching time	Turn-on time	_	_	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	_	160	_	
	Storage Time	_	_		_	500	_	ns
	Fall time	_	-		_	130	-	

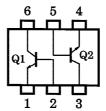
Note: hfe Classification

A: 200~700, B: 350~1200

Marking

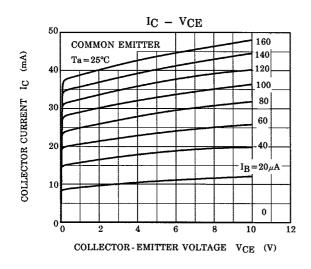
Equivalent Circuit (Top View)

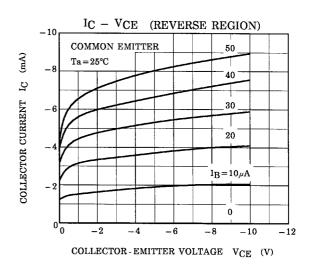


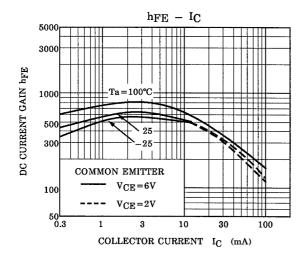


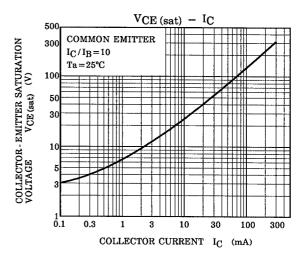
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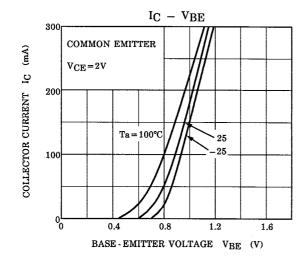
(Q1,Q2 Common)

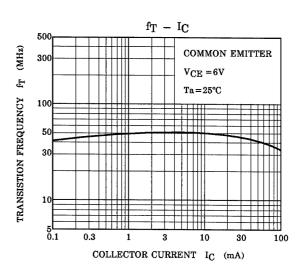






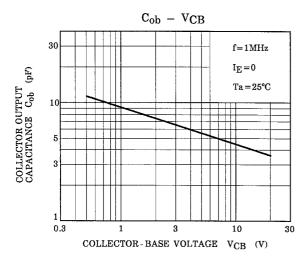


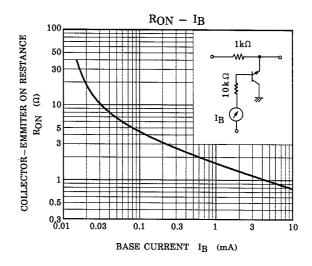


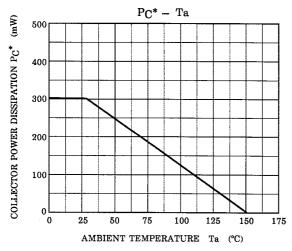


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(Q1,Q2 Common)







*: Total Rating

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